Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/629,687	CHANG ET AL.	
Examiner	Art Unit	_
Ninh H. Nguyen	3745	

SEARCHED					
Class	Subclass	Date	Examiner		
415	211.2	11/17/2005	NHN		
	220				
	221				
		_			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East search	11/17/2005	NHN	
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